
John L. Shew

2664

SEARCHED			
Class	Subclass	Date	Examiner
340	2.1,2.23	6/7/2005	JS
	2.24,3.1		
370	229,230.1	6/7/2005	JS
	232,233		
	235,237		
	238,238.1		
	252,351		
	389,395.1		
	395.21		
	395.32		
	395.41		
	400,468		
	477,537		
	538,540		

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

[illegible]

Search Notes (continued)

Application/Control No.

09/924,054

Examiner

John L. Shew

Applicant(s)/Patent under
Reexamination

SAITO, HIROYUKI

Art Unit

2664

SEARCHED

Class	Subclass	Date	Examiner
709	220,221	6/7/2005	JS
	222,225		
	226,238		
	239		

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR